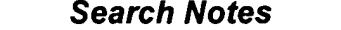


<b>Search Notes</b> 	<b>Application/Control No.</b> 10/519,895	<b>Applicant(s)/Patent under Reexamination</b> OKAYAMA ET AL.
	<b>Examiner</b> Eric Wendler	<b>Art Unit</b> 2824

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner